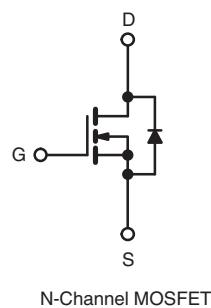
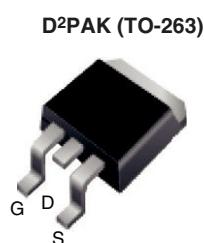


D Series Power MOSFET

PRODUCT SUMMARY	
V_{DS} (V) at T_J max.	550
$R_{DS(on)}$ max. at 25 °C (Ω)	$V_{GS} = 10$ V 0.85
Q_g (max.) (nC)	30
Q_{gs} (nC)	4
Q_{gd} (nC)	7
Configuration	Single



ORDERING INFORMATION

Package	D ² PAK (TO-263)
Lead (Pb)-free and Halogen-free	SiHB8N50D-GE3

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ °C, unless otherwise noted)

PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	500	V
Gate-Source Voltage			V_{GS}	± 30	
Gate-Source Voltage AC ($f > 1$ Hz)				30	
Continuous Drain Current ($T_J = 150$ °C)	V_{GS} at 10 V		I_D	8.7	A
				5.5	
Pulsed Drain Current ^a			I_{DM}	18	
Linear Derating Factor				1.25	W/°C
Single Pulse Avalanche Energy ^b			E_{AS}	29	mJ
Maximum Power Dissipation			P_D	156	W
Operating Junction and Storage Temperature Range			T_J, T_{stg}	- 55 to + 150	°C
Drain-Source Voltage Slope	$T_J = 125$ °C		dV/dt	24	V/ns
Reverse Diode dV/dt^d				0.37	
Soldering Recommendations (Peak Temperature) ^c	for 10 s			300	°C

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, $L = 2.3$ mH, $R_g = 25$ Ω, $I_{AS} = 5$ A.
- c. 1.6 mm from case.
- d. $I_{SD} \leq I_D$, starting $T_J = 25$ °C.



RoHS
COMPLIANT
HALOGEN
FREE

FEATURES

- Optimal Design
 - Low Area Specific On-Resistance
 - Low Input Capacitance (C_{iss})
 - Reduced Capacitive Switching Losses
 - High Body Diode Ruggedness
 - Avalanche Energy Rated (UIS)
- Optimal Efficiency and Operation
 - Low Cost
 - Simple Gate Drive Circuitry
 - Low Figure-of-Merit (FOM): $R_{on} \times Q_g$
 - Fast Switching
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

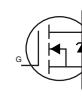
APPLICATIONS

- Consumer Electronics
 - Displays (LCD or Plasma TV)
- Server and Telecom Power Supplies
 - SMPS
- Industrial
 - Welding
 - Induction Heating
 - Motor Drives
- Battery Chargers

THERMAL RESISTANCE RATINGS

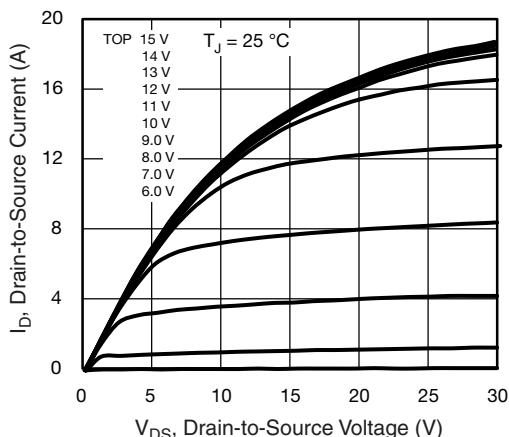
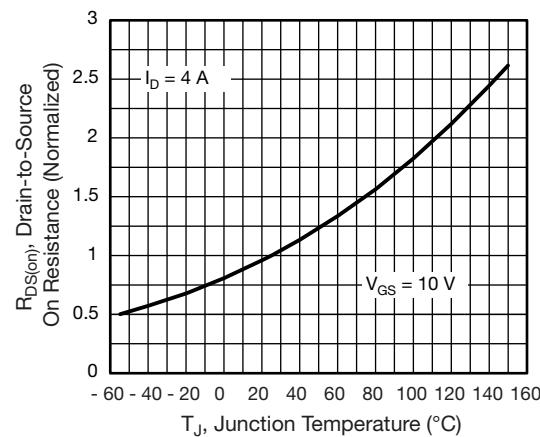
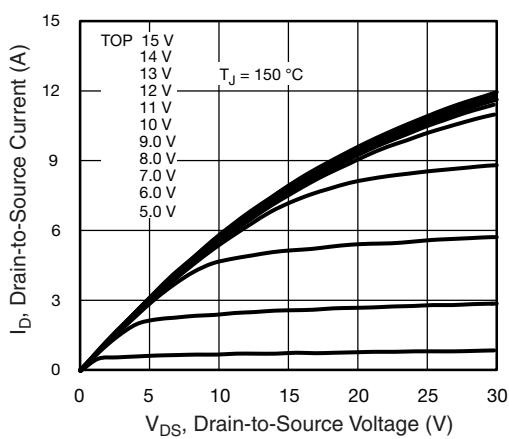
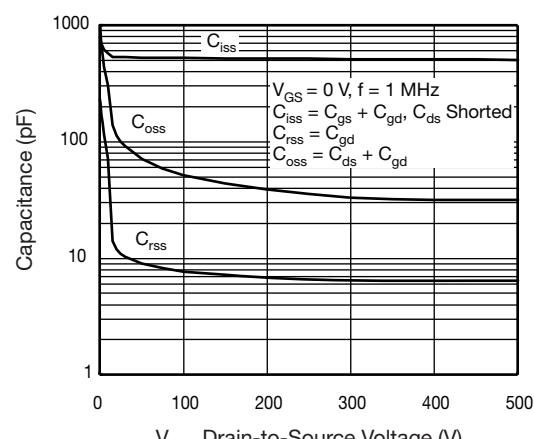
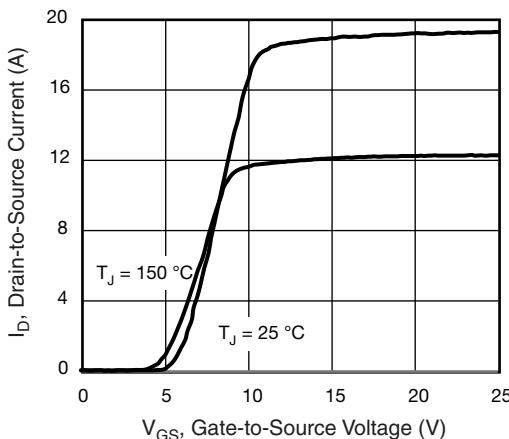
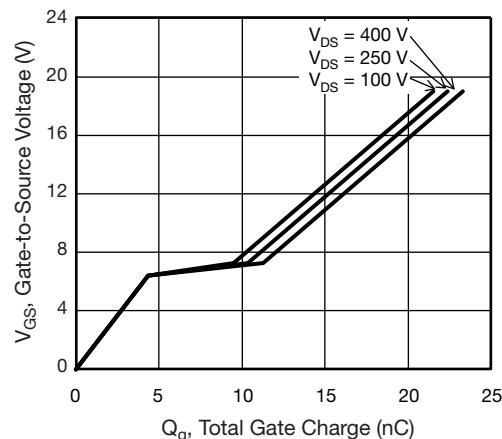
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R_{thJA}	-	62	°C/W
Maximum Junction-to-Case (Drain)	R_{thJC}	-	0.8	

SPECIFICATIONS (T_J = 25 °C, unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}$	$I_D = 250 \mu\text{A}$	500	-	-	V	
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25 °C, $I_D = 250 \mu\text{A}$		-	0.58	-	V/°C	
Gate-Source Threshold Voltage (N)	$V_{GS(th)}$	$V_{DS} = V_{GS}$	$I_D = 250 \mu\text{A}$	3	-	5	V	
Gate-Source Leakage	I_{GSS}	$V_{GS} = \pm 30 \text{ V}$		-	-	± 100	nA	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 500 \text{ V}$, $V_{GS} = 0 \text{ V}$		-	-	1	μA	
		$V_{DS} = 400 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 125 \text{ °C}$		-	-	10		
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 4 \text{ A}$	-	0.70	0.85	Ω	
Forward Transconductance ^a	g_{fs}	$V_{DS} = 20 \text{ V}$, $I_D = 4 \text{ A}$		-	3	-	S	
Dynamic								
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V}$, $V_{DS} = 100 \text{ V}$, $f = 1 \text{ MHz}$		-	527	-	pF	
Output Capacitance	C_{oss}			-	52	-		
Reverse Transfer Capacitance	C_{rss}			-	8	-		
Effective Output Capacitance, Energy Related ^b	$C_{o(er)}$	$V_{DS} = 0 \text{ V to } 400 \text{ V}$, $V_{GS} = 0 \text{ V}$		-	46	-		
Effective Output Capacitance, Time Related ^c	$C_{o(tr)}$			-	64	-		
Total Gate Charge	Q_g	$V_{GS} = 10 \text{ V}$	$I_D = 4 \text{ A}$, $V_{DS} = 400 \text{ V}$	-	15	30	nC	
Gate-Source Charge	Q_{gs}			-	4	-		
Gate-Drain Charge	Q_{gd}			-	7	-		
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 400 \text{ V}$, $I_D = 4 \text{ A}$ $R_g = 9.1 \Omega$, $V_{GS} = 10 \text{ V}$		-	13	26	ns	
Rise Time	t_r			-	16	32		
Turn-Off Delay Time	$t_{d(off)}$			-	17	34		
Fall Time	t_f			-	11	22		
Gate Input Resistance	R_g	$f = 1 \text{ MHz}$, open drain		-	1.8	-	Ω	
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I_S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	8	A	
Pulsed Diode Forward Current	I_{SM}			-	-	32		
Diode Forward Voltage	V_{SD}	$T_J = 25 \text{ °C}$, $I_S = 4 \text{ A}$, $V_{GS} = 0 \text{ V}$		-	-	1.2	V	
Reverse Recovery Time	t_{rr}	$T_J = 25 \text{ °C}$, $I_F = I_S = 4 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$, $V_R = 20 \text{ V}$		-	308	-	ns	
Reverse Recovery Charge	Q_{rr}			-	1.8	-		
Reverse Recovery Current	I_{RRM}			-	11	-	A	

Notes

- Repetitive rating; pulse width limited by maximum junction temperature.
- $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .
- $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig. 1 - Typical Output Characteristics

Fig. 4 - Normalized On-Resistance vs. Temperature

Fig. 2 - Typical Output Characteristics

Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

Fig. 3 - Typical Transfer Characteristics

Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

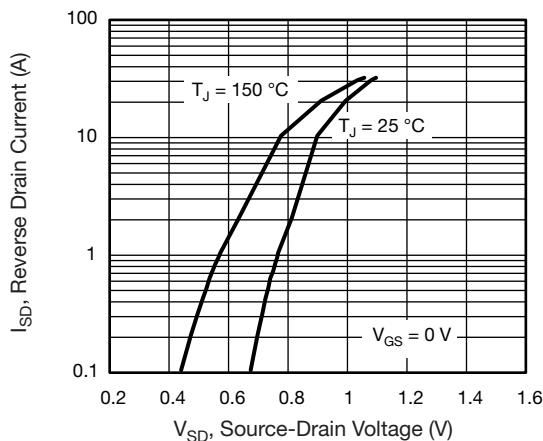


Fig. 7 - Typical Source-Drain Diode Forward Voltage

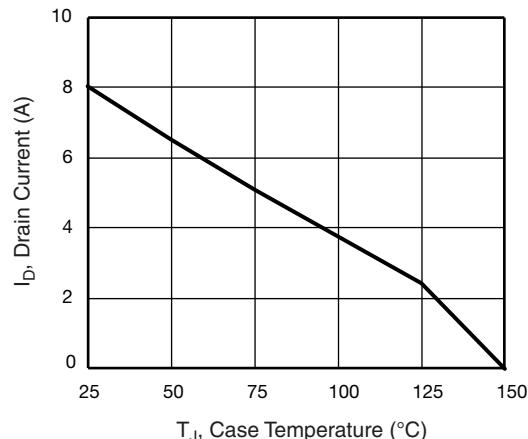


Fig. 9 - Maximum Drain Current vs. Case Temperature

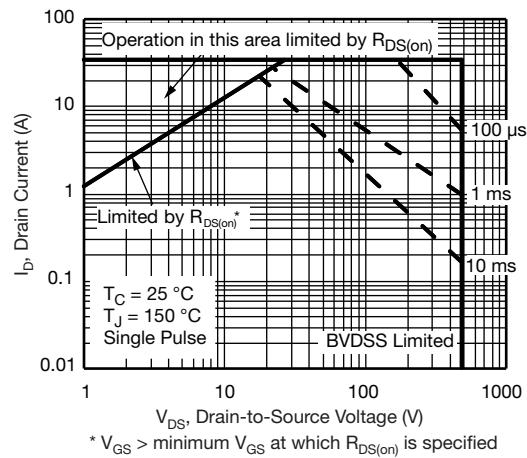


Fig. 8 - Maximum Safe Operating Area

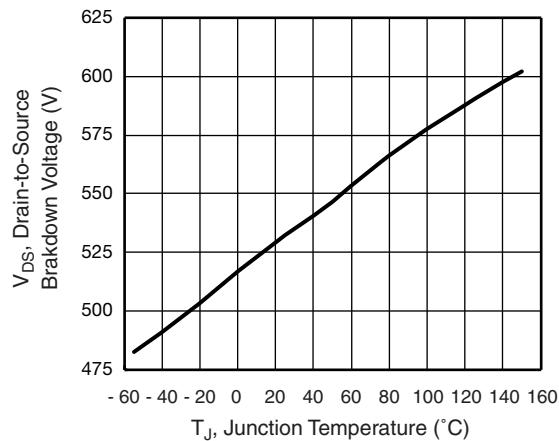


Fig. 10 - Typical Drain-to-Source Voltage vs. Temperature

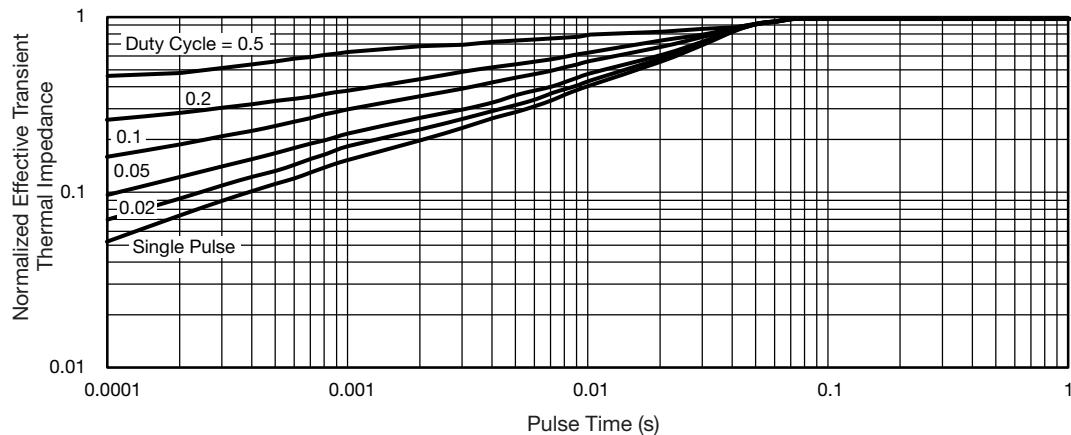


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case

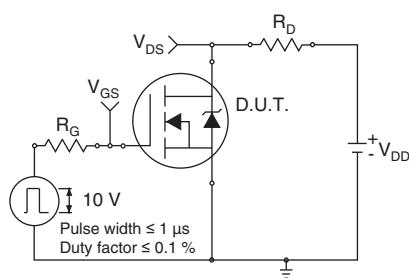


Fig. 12 - Switching Time Test Circuit

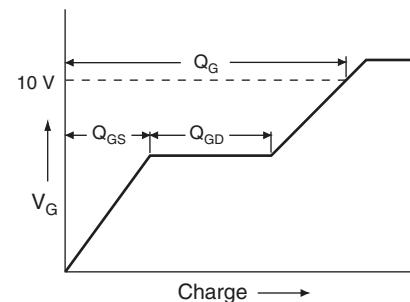


Fig. 16 - Basic Gate Charge Waveform

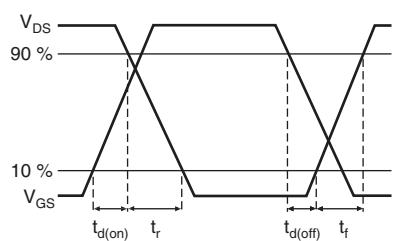


Fig. 13 - Switching Time Waveforms

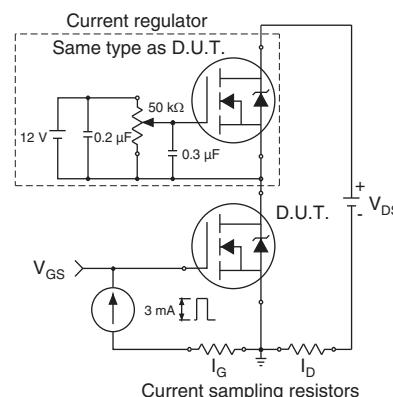


Fig. 17 - Gate Charge Test Circuit

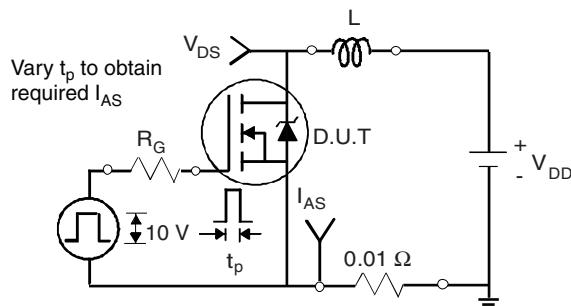


Fig. 14 - Unclamped Inductive Test Circuit

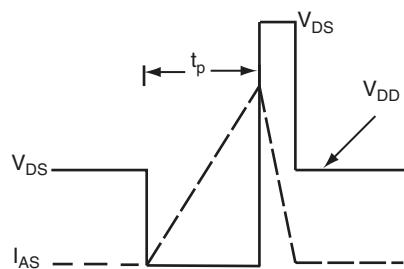
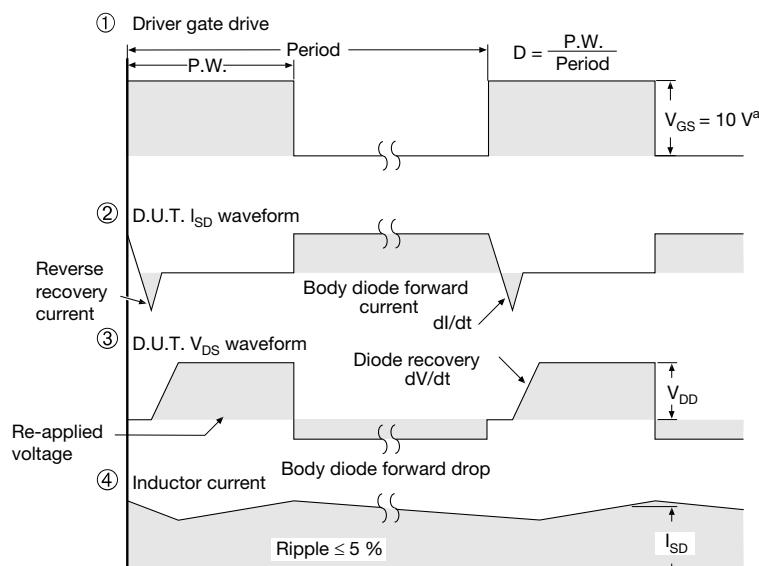
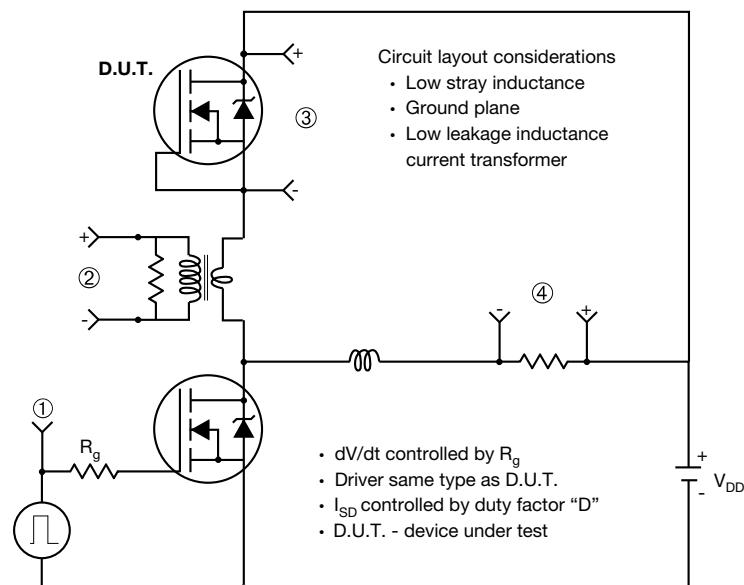


Fig. 15 - Unclamped Inductive Waveforms

Peak Diode Recovery dV/dt Test Circuit

Note

a. $V_{GS} = 5 \text{ V}$ for logic level devices

Fig. 18 - For N-Channel

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